

STARPOWER

SEMICONDUCTOR

IGBT

GD1000HFX170P2S

1700V/1000A 2 in one-package

General Description

STARPOWER IGBT Power Module provides ultra low conduction loss as well as short circuit ruggedness. They are designed for the applications such as wind power.

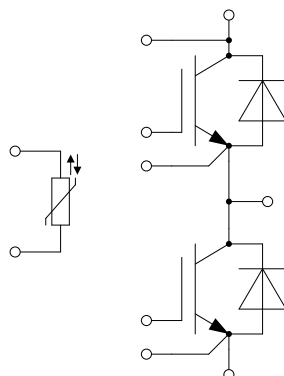
Features

- Low $V_{CE(sat)}$ Trench IGBT technology
- 10 μ s short circuit capability
- $V_{CE(sat)}$ with positive temperature coefficient
- Maximum junction temperature 175°C
- Enlarged Diode for regenerative operation
- Isolated copper baseplate using DBC technology
- High power and thermal cycling capability

Typical Applications

- High Power Converter
- Wind Power
- Auxiliary Inverter

Equivalent Circuit Schematic



Absolute Maximum Ratings $T_C=25^{\circ}\text{C}$ unless otherwise noted**IGBT**

Symbol	Description	Value	Unit
V_{CES}	Collector-Emitter Voltage	1700	V
V_{GES}	Gate-Emitter Voltage	± 20	V
I_C	Collector Current @ $T_C=25^{\circ}\text{C}$ @ $T_C=100^{\circ}\text{C}$	1604 1000	A
I_{CM}	Pulsed Collector Current $t_p=1\text{ms}$	2000	A
P_D	Maximum Power Dissipation @ $T_j=175^{\circ}\text{C}$	6.25	kW

Diode

Symbol	Description	Value	Unit
V_{RRM}	Repetitive Peak Reverse Voltage	1700	V
I_F	Diode Continuous Forward Current	1000	A
I_{FM}	Diode Maximum Forward Current $t_p=1\text{ms}$	2000	A

Module

Symbol	Description	Value	Unit
T_{jmax}	Maximum Junction Temperature	175	$^{\circ}\text{C}$
T_{jop}	Operating Junction Temperature	-40 to +150	$^{\circ}\text{C}$
T_{STG}	Storage Temperature Range	-40 to +150	$^{\circ}\text{C}$
V_{ISO}	Isolation Voltage RMS, $f=50\text{Hz}$, $t=1\text{min}$	4000	V

IGBT Characteristics $T_C=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage	$I_C=1000\text{A}, V_{GE}=15\text{V}, T_j=25^{\circ}\text{C}$		1.95	2.40	V
		$I_C=1000\text{A}, V_{GE}=15\text{V}, T_j=125^{\circ}\text{C}$		2.40		
		$I_C=1000\text{A}, V_{GE}=15\text{V}, T_j=150^{\circ}\text{C}$		2.50		
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	$I_C=40.0\text{mA}, V_{CE}=V_{GE}, T_j=25^{\circ}\text{C}$	5.6	6.2	6.8	V
I_{CES}	Collector Cut-Off Current	$V_{CE}=V_{CES}, V_{GE}=0\text{V}, T_j=25^{\circ}\text{C}$			5.0	mA
I_{GES}	Gate-Emitter Leakage Current	$V_{GE}=V_{GES}, V_{CE}=0\text{V}, T_j=25^{\circ}\text{C}$			400	nA
R_{Gint}	Internal Gate Resistance			2.3		Ω
C_{ies}	Input Capacitance	$V_{CE}=25\text{V}, f=1\text{MHz}, V_{GE}=0\text{V}$		108		nF
C_{res}	Reverse Transfer Capacitance			2.63		nF
Q_G	Gate Charge	$V_{GE}=-15\dots+15\text{V}$		9.43		μC
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=900\text{V}, I_C=1000\text{A}, R_{Gon}=1.2\Omega, R_{Goff}=1.8\Omega, V_{GE}=\pm 15\text{V}, T_j=25^{\circ}\text{C}$		468		ns
t_r	Rise Time			95		ns
$t_{d(off)}$	Turn-Off Delay Time			850		ns
t_f	Fall Time			363		ns
E_{on}	Turn-On Switching Loss			292		mJ
E_{off}	Turn-Off Switching Loss			230		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=900\text{V}, I_C=1000\text{A}, R_{Gon}=1.2\Omega, R_{Goff}=1.8\Omega, V_{GE}=\pm 15\text{V}, T_j=125^{\circ}\text{C}$		480		ns
t_r	Rise Time			120		ns
$t_{d(off)}$	Turn-Off Delay Time			1031		ns
t_f	Fall Time			613		ns
E_{on}	Turn-On Switching Loss			439		mJ
E_{off}	Turn-Off Switching Loss			325		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=900\text{V}, I_C=1000\text{A}, R_{Gon}=1.2\Omega, R_{Goff}=1.8\Omega, V_{GE}=\pm 15\text{V}, T_j=150^{\circ}\text{C}$		480		ns
t_r	Rise Time			120		ns
$t_{d(off)}$	Turn-Off Delay Time			1040		ns
t_f	Fall Time			708		ns
E_{on}	Turn-On Switching Loss			447		mJ
E_{off}	Turn-Off Switching Loss			347		mJ
I_{SC}	SC Data	$t_p \leq 10\mu\text{s}, V_{GE}=15\text{V}, T_j=150^{\circ}\text{C}, V_{CC}=1300\text{V}, V_{CEM} \leq 1700\text{V}$		4000		A

Diode Characteristics $T_C=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V_F	Diode Forward Voltage	$I_F=1000\text{A}, V_{GE}=0\text{V}, T_j=25^{\circ}\text{C}$		1.85	2.30	V
		$I_F=1000\text{A}, V_{GE}=0\text{V}, T_j=125^{\circ}\text{C}$		2.00		
		$I_F=1000\text{A}, V_{GE}=0\text{V}, T_j=150^{\circ}\text{C}$		2.05		
Q_r	Recovered Charge	$V_R=900\text{V}, I_F=1000\text{A},$ $-di/dt=9200\text{A}/\mu\text{s}, V_{GE}=-15\text{V}$ $T_j=25^{\circ}\text{C}$		270		μC
I_{RM}	Peak Reverse Recovery Current			1155		A
E_{rec}	Reverse Recovery Energy			132		mJ
Q_r	Recovered Charge	$V_R=900\text{V}, I_F=1000\text{A},$ $-di/dt=9200\text{A}/\mu\text{s}, V_{GE}=-15\text{V}$ $T_j=125^{\circ}\text{C}$		451		μC
I_{RM}	Peak Reverse Recovery Current			1260		A
E_{rec}	Reverse Recovery Energy			241		mJ
Q_r	Recovered Charge	$V_R=900\text{V}, I_F=1000\text{A},$ $-di/dt=9200\text{A}/\mu\text{s}, V_{GE}=-15\text{V}$ $T_j=150^{\circ}\text{C}$		528		μC
I_{RM}	Peak Reverse Recovery Current			1250		A
E_{rec}	Reverse Recovery Energy			294		mJ

NTC Characteristics $T_C=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
R_{25}	Rated Resistance			5.0		k Ω
$\Delta R/R$	Deviation of R_{100}	$T_C=100^{\circ}\text{C}, R_{100}=493.3\Omega$	-5		5	%
P_{25}	Power Dissipation				20.0	mW
$B_{25/50}$	B-value	$R_2=R_{25}\exp[B_{25/50}(1/T_2-1/(298.15\text{K}))]$		3375		K
$B_{25/80}$	B-value	$R_2=R_{25}\exp[B_{25/80}(1/T_2-1/(298.15\text{K}))]$		3411		K
$B_{25/100}$	B-value	$R_2=R_{25}\exp[B_{25/100}(1/T_2-1/(298.15\text{K}))]$		3433		K

Module Characteristics $T_C=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Min.	Typ.	Max.	Unit
L_{CE}	Stray Inductance		10		nH
$R_{CC'+EE'}$	Module Lead Resistance, Terminal to Chip		0.20		m Ω
R_{thJC}	Junction-to-Case (per IGBT)			24.0	K/kW
	Junction-to-Case (per Diode)			48.0	
R_{thCH}	Case-to-Heatsink (per IGBT)		9.0		K/kW
	Case-to-Heatsink (per Diode)		18.0		
	Case-to-Heatsink (per Module)		3.0		
M	Terminal Connection Torque, Screw M4	1.8		2.1	N.m
	Terminal Connection Torque, Screw M8	8.0		10	
	Mounting Torque, Screw M5	3.0		6.0	
G	Weight of Module		1210		g

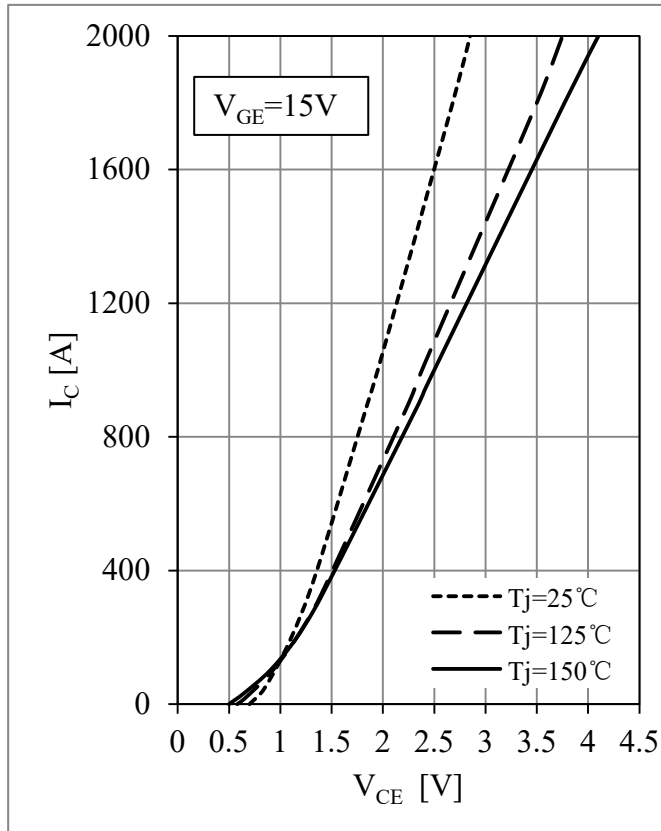


Fig 1. IGBT Output Characteristics

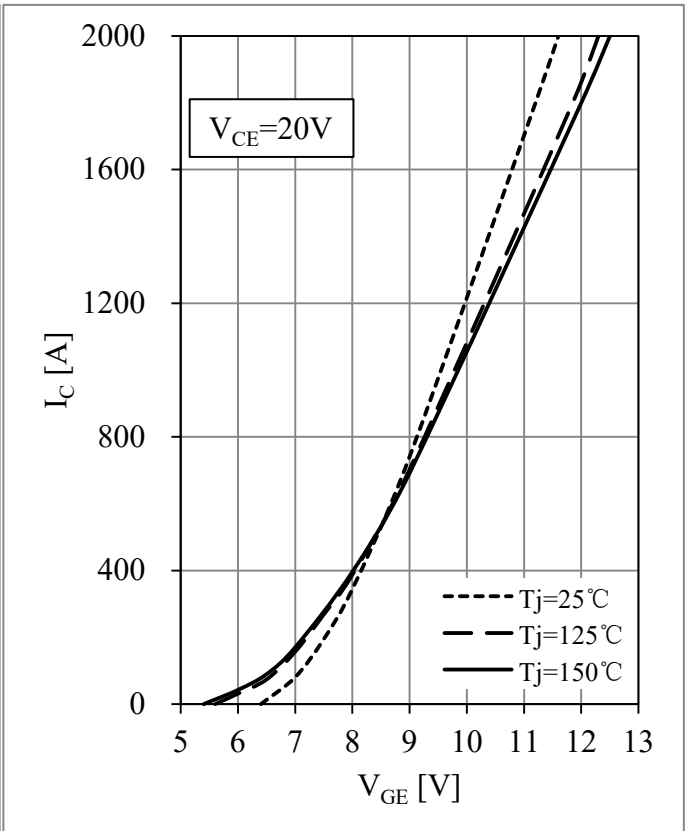
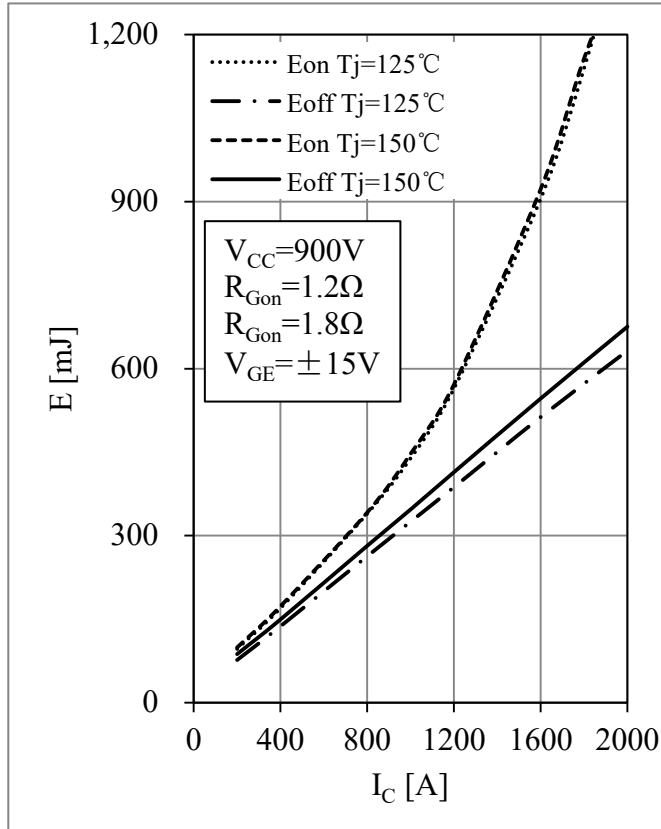
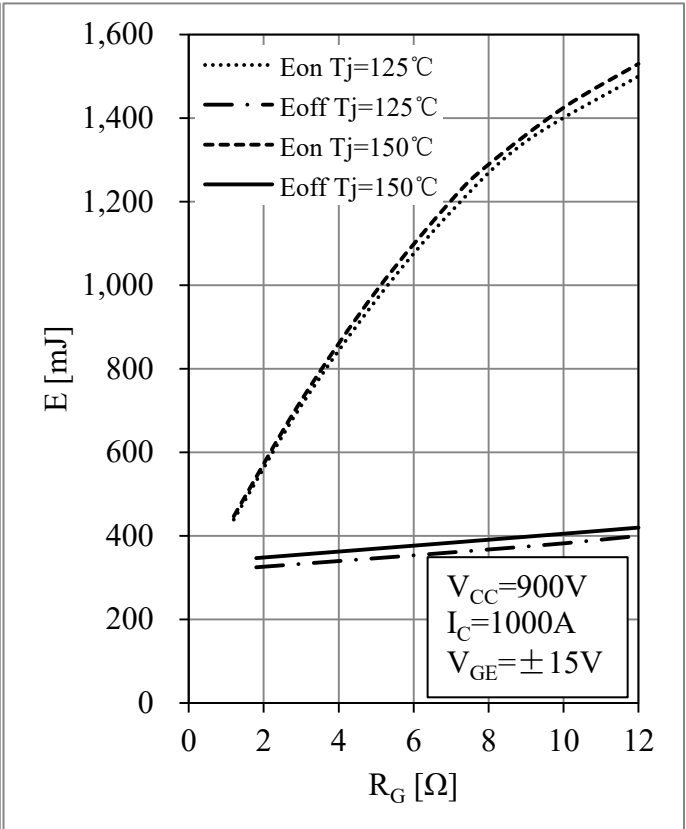


Fig 2. IGBT Transfer Characteristics

Fig 3. IGBT Switching Loss vs. I_C Fig 4. IGBT Switching Loss vs. R_G

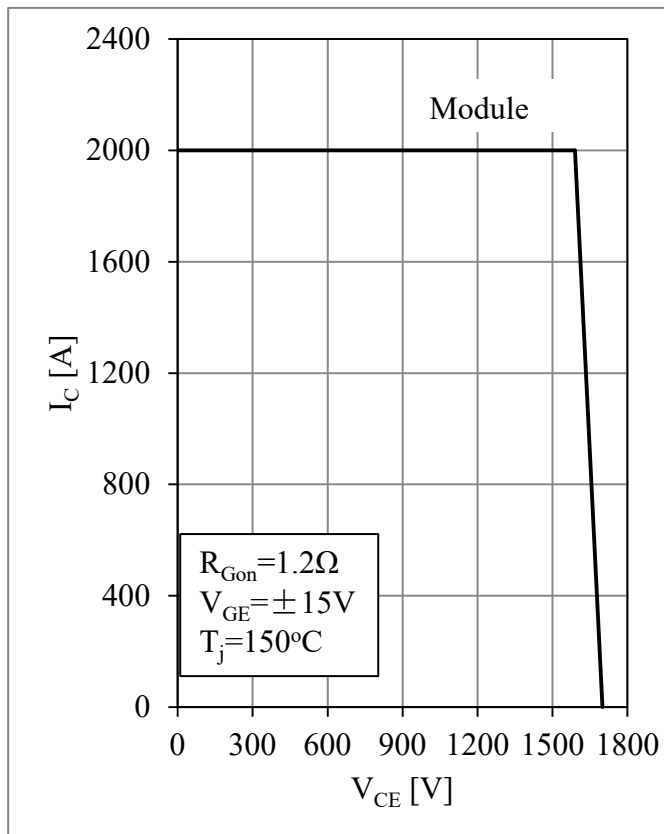


Fig 5. RBSOA

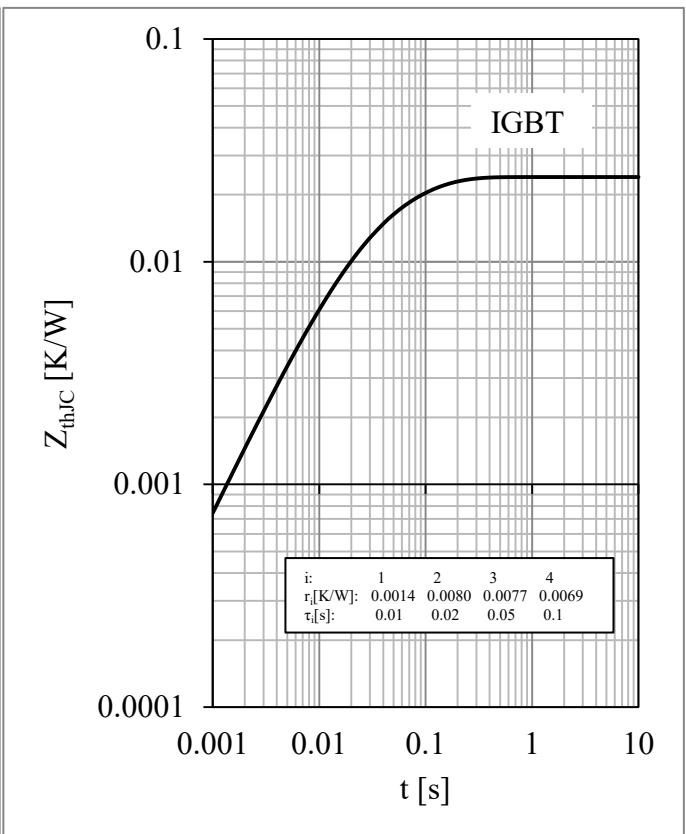


Fig 6. IGBT Transient Thermal Impedance

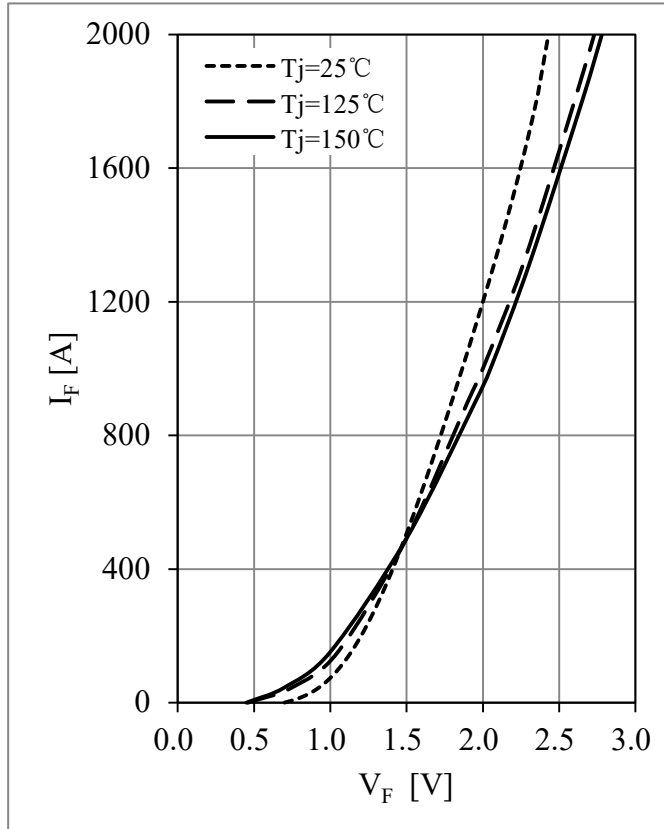
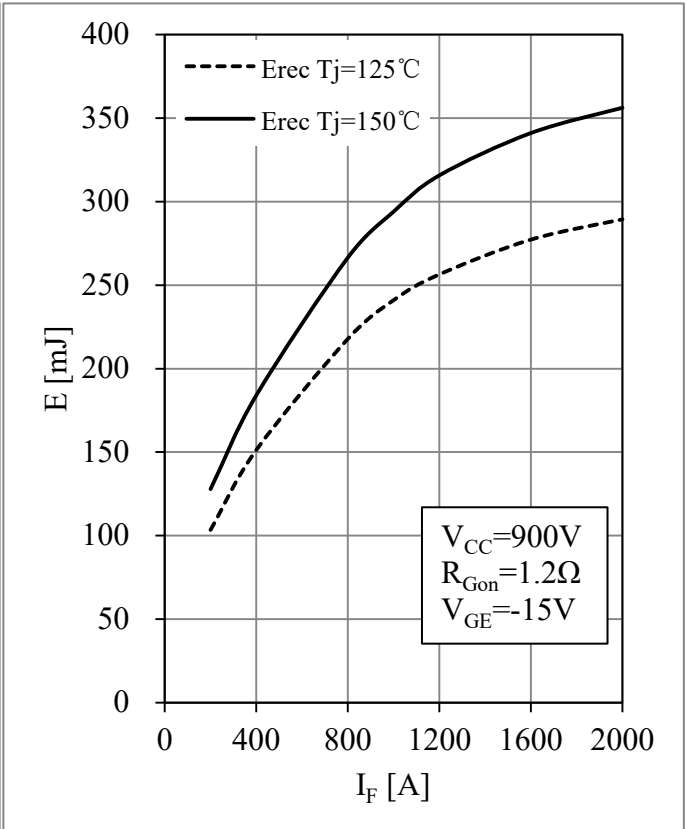


Fig 7. Diode Forward Characteristics

Fig 8. Diode Switching Loss vs. I_F

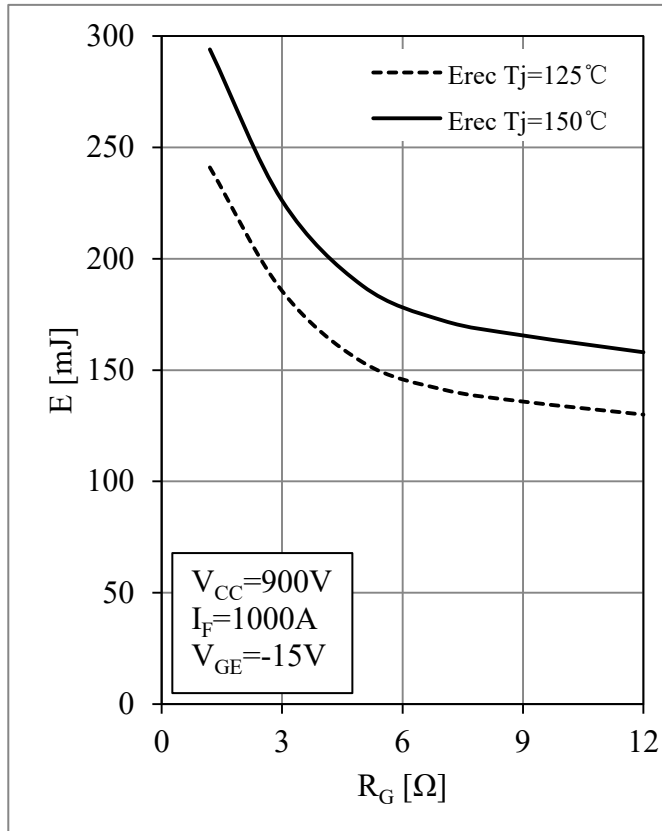
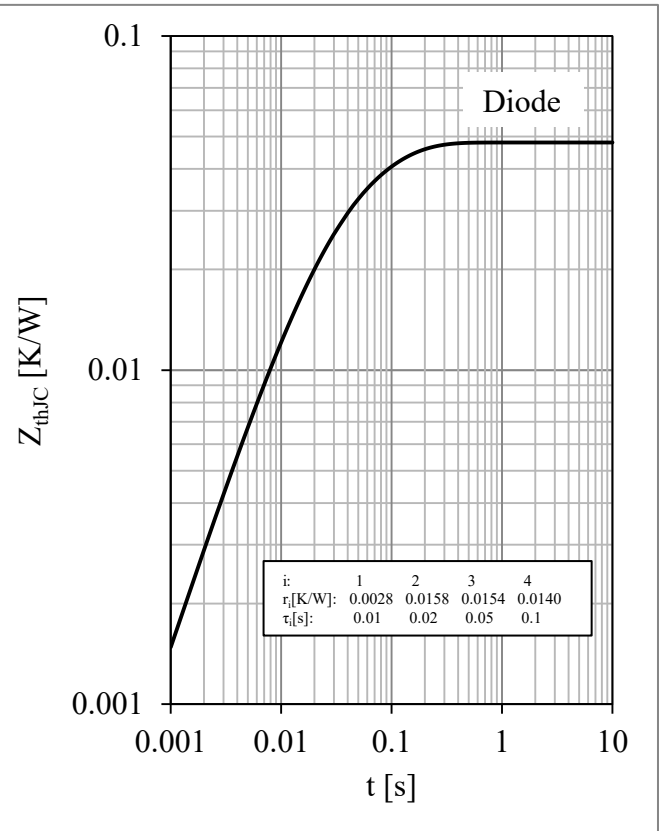
Fig 9. Diode Switching Loss vs. R_G 

Fig 10. Diode Transient Thermal Impedance

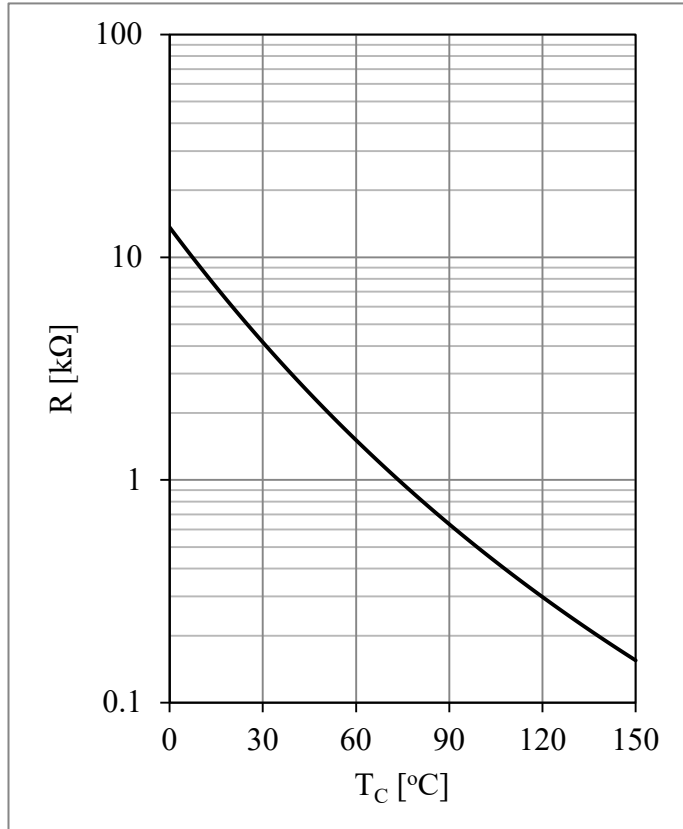
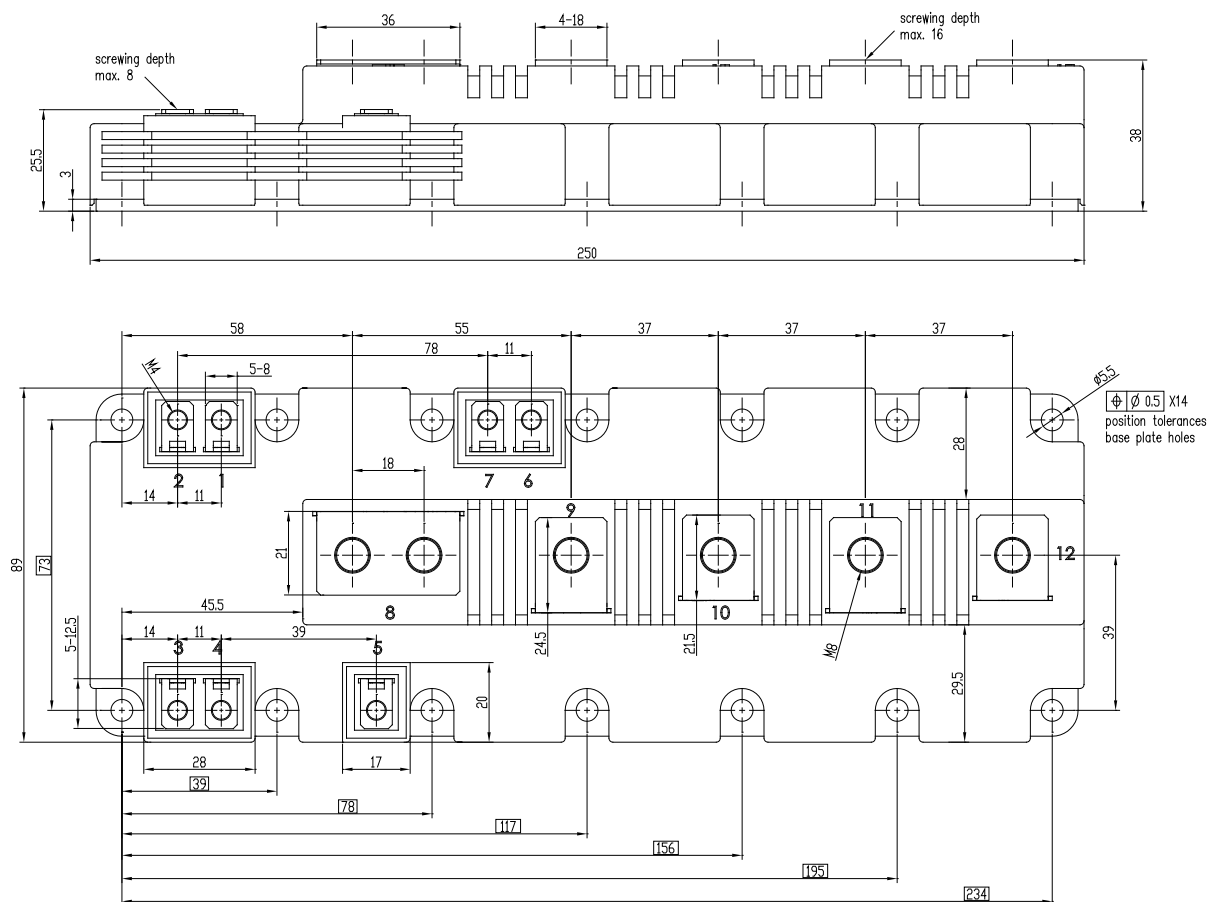


Fig 11. NTC Temperature Characteristic

Dimensions in Millimeters



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